Searcl	n Notes	

Application/Control No.	Applicant(s)/Patent un Reexamination	der
10/765,276	TAKEOKA ET AL.	
Examiner	Art Unit	
Vuthe Siek	2825	

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SEARCHED					
Class	Subclass	Date ·	Examiner		
716	4-6	2/22/2008	VS		
702	58,59	5/8/2006	vs		
702	117-119	5/8/2006	vs		
702	185,189	5/8/2006	vs		
. 324	238,500	5/8/2006	vs		
<b>324</b>	512,527	5/8/2006	vs		
714	700,744	5/8/2006	vs		
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INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST ALL DATABASES & IEEE (SEE SEARCH HISTORY PRINTOUTS)	2/22/2006	vs		
su Printo-ts	3/1/67	٧S		